



Search Notes 	Application/Control No. 10076367	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner Mills, Donald L	Art Unit 2616

Notes	Date	Examiner
EAST (US PGPUBS, USPATs, EPO, JPO, IBM, DERWENT)	06/15/2006	DLM
IEEE - www.ieee.ieeeexplore.org - packet filtering	06/15/2006	DLM
Internet - google.com - packet filtering	06/15/2006	DLM
U.S. Patent and Trademark Office		Part of Paper No.: 20060615

<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10076367</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LEE ET AL.</p>
	<p>Examiner</p> <p>Mills, Donald L</p>	<p>Art Unit</p> <p>2616</p>

Class	SubClass	Date	Examiner
370	230,230.1,235,236.2,298,401,412,4 28,429,465	06/14/2006	DLM
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